

# Platinum-Oxide Species Formed on Progressive Oxidation of Platinum Crystallites Supported on Silica and Silica–Alumina

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Samples of platinum crystallites finely dispersed on silica and silica–alumina were prepared by impregnating a series of SiO<sub>2</sub>–Al<sub>2</sub>O<sub>3</sub> supports with aqueous PtCl<sub>4</sub> solutions. Reduced platinum samples were oxidized by dioxygen to examine variations of platinum-oxides (Pt-O<sub>x</sub>) species formed with the oxidation temperature (T<sub>0</sub>). Both PtO and PtO<sub>2</sub> species were verified to coexist on oxidized Pt/SiO<sub>2</sub> samples according to characterizations by techniques of X-ray photoelectron spectroscopy and temperature-programmed reduction (TPR). TPR spectra of oxidized platinum species dispersed on SiO<sub>2</sub>–Al<sub>2</sub>O<sub>3</sub> supports exhibited six peaks of different reduction temperatures (T<sub>r</sub>). These peaks were assigned to PtO and PtO<sub>2</sub> species dispersed in silica-rich grains (T<sub>r</sub> = –40 and 20°C, respectively), in alumina-rich grains (T<sub>r</sub> = 50 and 90°C), and in pores of the grain boundary (T<sub>r</sub> = 110 and 130°C), respectively. The contribution of these six species varied with both the temperature of oxidation treatments and the Al<sub>2</sub>O<sub>3</sub>/SiO<sub>2</sub> ratio of sample supports. © 1999 Academic Press

## 1. INTRODUCTION

Supported platinum catalysts are currently used in reactions of the catalytic combustion (1–3) and the partial oxidation (4–6). During these catalytic reactions, the surface platinum atoms on dispersed crystallites are reversibly changed between the oxidized state and the metallic state; i.e.,



In this equation, *x* and RH denote a chemical stoichiometry of platinum oxides and reductive molecules in catalytic systems, respectively.

The oxidation of supported platinum crystallites has been widely studied in the literature. A severe oxidation not only induced a change in their size distribution and morphology (7–14), but also generated platinum oxides of different stoichiometries (7, 14–25). In a recent TPR

(temperature-programmed reduction) study (21) on oxidation of Pt/Al<sub>2</sub>O<sub>3</sub> samples, oxidized platinum ions in four different environments, i.e., chemisorbed (PtO<sup>+</sup>), PtO, PtO<sub>2</sub>, and PtAl<sub>2</sub>O<sub>4</sub>, have been distinguished from their reduction temperatures in TPR traces. The relative contribution of these four species on oxidized samples varied significantly with the platinum dispersion and the oxidation temperature.

The support of catalysts generally has a prominent effect on behavior of dispersed active ingredients. Both the morphology and the reducibility of molybdenum oxides dispersed on SiO<sub>2</sub>–Al<sub>2</sub>O<sub>3</sub> were significantly affected by the support composition (26, 27). It becomes a pertinent topic to study “Whether the support can affect the oxidation of dispersed platinum.” In the literature, different platinum-oxide species [PtO (14, 25) or PtO<sub>2</sub> (24)] have been suggested as probable platinum oxide species on silica supported Pt/SiO<sub>2</sub> samples calcined at a temperature of 300°C (Table 1).

In this study, platinum oxide species formed on oxidation of a series of Pt/SiO<sub>2</sub>–Al<sub>2</sub>O<sub>3</sub> samples with different SiO<sub>2</sub>/Al<sub>2</sub>O<sub>3</sub> ratios in support composition were investigated with the established TPR technique. We want to report that the composition of supports also has a profound effect on the reductive properties of platinum oxides formed.

## 2. EXPERIMENTAL

### 2.1. Fresh and Reduced Pt/SiO<sub>2</sub> Samples

Pt/SiO<sub>2</sub> samples of different platinum loadings were prepared by impregnating SiO<sub>2</sub> powders (Carbosil M-5, surface area 200 m<sup>2</sup> g<sup>–1</sup>) with aqueous PtCl<sub>4</sub> solutions by the incipient-wetness method. Obtained slurries were subsequently dried overnight at 110°C, calcined for 4 h at 300°C and stored as fresh samples. A major portion of each fresh sample was then reduced by flowing hydrogen for 2 h at 300°C to convert supported PtO<sub>x</sub>Cl<sub>y</sub> into chloride-free Pt crystallites (7, 21) and is described in this paper as the reduced sample.

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**TABLE 1**  
**TPR Characterization of Silica Supported Platinum Oxide Species Suggested in Literature**

Authors	Sample	Oxidation condition	TPR		Oxide species	Ref.
			$T_r$ (°C)	$N_O/N_{Pt}$		
Bond <i>et al.</i>	6.3% Pt/SiO <sub>2</sub> (EUROPT-1)	TPO upward to 300°C	-60 and 20	0.9	PtO	14
Sachtler <i>et al.</i>	Pt/SiO <sub>2</sub>	300°C oxidation	-15 and 30	0.95	PtO	25
Maccabe <i>et al.</i>	0.7 and 5.2% Pt/SiO <sub>2</sub>	300°C oxidation	-70-130	2 (assumed)	PtO <sub>2</sub>	24
This study	1.0 and 4.9% Pt/SiO <sub>2</sub>	25-600°C oxidation	-50 and 20	0.23-1.21	PtO and PtO <sub>2</sub>	

### 2.2. Pt/SiO<sub>2</sub>-Al<sub>2</sub>O<sub>3</sub> Samples

Three kinds of commercial silica-alumina powders from Wako Co. were used as the starting supports. Their SiO<sub>2</sub>/Al<sub>2</sub>O<sub>3</sub> weight ratios were 80/20 (hereafter named as SA-80), 75/25 (SA-75), and 40/60 (SA-40), respectively. Supported Pt/SiO<sub>2</sub>-Al<sub>2</sub>O<sub>3</sub> samples with a nominal platinum loading of 5 wt% were prepared by impregnating the SiO<sub>2</sub>-Al<sub>2</sub>O<sub>3</sub> powders with a PtCl<sub>4</sub> solution. The impregnated samples were pretreated with an overnight drying at 110°C and a 4-h calcination at 300°C. These fresh samples were subsequently reduced for 2 h at 300°C, and named as reduced Pt/SA-80, Pt/SA-75, and Pt/SA-40, respectively.

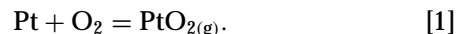
### 2.3. Oxidized Samples

Each reduced sample (Pt/SiO<sub>2</sub> or Pt/SiO<sub>2</sub>-Al<sub>2</sub>O<sub>3</sub>) was divided into several portions. They were oxidized in a gaseous flow of 5 vol% O<sub>2</sub> in He for 2 h at different predetermined oxidation temperatures ( $T_O = -100, -40, 25, 100, 300, 400, 500, \text{ or } 600^\circ\text{C}$ ) to convert supported platinum crystallites

into oxidized states. Variations in the platinum loading and the oxidation state of platinum on these oxidized samples were characterized by ICP and TPR techniques.

### 2.4. ICP Measurements

Loadings of platinum on reduced samples were analyzed by a Perkin-Elmer Sciex Elan 5000 ICP-MS. Each sample was pretreated with a 2-h dehydration at 200°C and a complete dissolution in aqua regia. Measured platinum loading on Pt/SiO<sub>2</sub> samples decreased with the temperature of oxidation treatments when  $T_O > 400^\circ\text{C}$  (Table 2), probably due to an increased extent of the following sublimation reaction (9, 28):



### 2.5. TPR Characterizations

TPR studies were performed in a fixed bed apparatus described in the previous report (29). A 30 ml min<sup>-1</sup> flow

**TABLE 2**  
**Effects of Oxidation Temperature ( $T_O$ ) on Pt Loadings and the TPR Characterization of Silica Supported Platinum Samples**

Sample (Dispersion $D = N_{H_1}/N_{Pt}^s$ <sup>a</sup> )	$T_O$ (°C)	ICP/MS (Pt wt%)	TPR peak (area %)		Total peak area, H <sub>2</sub> consumption in TPR (10 <sup>-5</sup> mol)	$N_O/N_{Pt}$ <sup>b</sup>
			$T_r = -50^\circ\text{C}$ (S <sub>1</sub> )	$T_r = 20^\circ\text{C}$ (S <sub>2</sub> )		
4.9% Pt/SiO <sub>2</sub> ( $D = 30\%$ )	-100	—	100	0	0.85	0.23
	-40	—	100	0	1.52	0.41
	25	4.9	95	5	2.77	0.74
	100	4.9	88	12	3.67	0.98
	300	4.8	75	25	3.83	1.03
	400	4.0	70	30	3.76	1.21
	500	3.9	80	20	3.32	1.10
1.0% Pt/SiO <sub>2</sub> ( $D = 50\%$ )	600	3.4	85	15	2.60	0.99
	25	—	90	10	0.69	0.91
	300	1.0	75	25	0.92	1.19
	500	0.9	70	30	0.96	1.25

<sup>a</sup>  $N_{H_1}$ , monolayer uptake of hydrogen atom from H<sub>2</sub> chemisorption at 25°C. Assuming that  $N_{H_1}/N_{Pt}^s = 1.1$  (29).

<sup>b</sup>  $N_{Pt}$ , number of platinum atom measured from ICP/MS.

$N_O$ , uptake of oxygen atom calculated from H<sub>2</sub> consumption in TPR.

TABLE 3

Reduction Temperature ( $T_r$ ) in TPR for Various Platinum Oxide Species Formed on  $\gamma$ - $\text{Al}_2\text{O}_3$  and  $\text{SiO}_2$  Supports

Oxide species	$T_r$ ( $^\circ\text{C}$ )	
	Pt/ $\text{Al}_2\text{O}_3^a$	Pt/ $\text{SiO}_2^b$
Bulk $\text{PtO}_x\text{Cl}_y$	150–300	~60
Intersurfacial $\text{PtO}_x\text{Cl}_y$	300–400	~100
$\text{Pt}^\ominus\text{O}$	–25	–60
PtO	50	–50
$\text{PtO}_2$	100	20
Pt-aluminate	220	—
Pt-silicate	—	None

<sup>a</sup> The data were collected from Ref. 21 in our previous study.

<sup>b</sup> In this study.

of 10 vol%  $\text{H}_2$  in Ar was used as the reducing gas when the sample temperature was raised from  $-80$  to  $400^\circ\text{C}$  at a constant rate of  $7^\circ\text{C min}^{-1}$ . The rate of hydrogen consumption during sample reductions was monitored by a thermal conductivity detector (TCD). The amount of oxygen atoms ( $N_{\text{O}}$ ) reduced in TPR experiments was measured from the integrated hydrogen consumption. Calculated  $N_{\text{O}}/N_{\text{Pt}}$  ratios (where  $N_{\text{Pt}}$  denotes the number of platinum atoms in each sample) from different oxidized samples are listed in Tables 2 and 4. The software used for peak integration was provided by Scientific Information Service Corporation (SISC).

## 2.6. Hydrogen Chemisorption

Dispersions ( $D$ ) of platinum on reduced Pt/ $\text{SiO}_2$  and Pt/ $\text{SiO}_2$ - $\text{Al}_2\text{O}_3$  samples were estimated by the hydrogen chemisorption measurements performed at room temperature under an assumption that  $N_{\text{H}}/N_{\text{Pt}}^{\text{S}} = 1.1$  (30) at the monolayer chemisorption. Prior to the chemisorption measurements, reduced samples were pretreated with an evacuation at  $300^\circ\text{C}$  for 1 h. The chemisorption was performed

TABLE 4

Effect of Oxidation Temperature ( $T_0$ ) on the TPR Characterization of Pt/ $\text{SiO}_2$ - $\text{Al}_2\text{O}_3$  Samples

Sample Dispersion, $D$	ICP/MS (Pt/wt%)	$N_{\text{O}}/N_{\text{Pt}}^a$ ratio after varied $T_0$ of oxidation					
		$T_0$ ( $^\circ\text{C}$ ) = 25	100	300	400	500	600
Pt/SA-80 ( $D=59\%$ )	4.81	0.46	0.83	1.25	1.26	1.16	0.43
Pt/SA-75 ( $D=51\%$ )	4.88	0.69	1.01	1.29	1.32	1.39	0.62
Pt/SA-40 ( $D=71\%$ )	4.76	0.74	1.03	1.36	1.49	1.41	0.66

<sup>a</sup>  $N_{\text{Pt}}$ , number of platinum atom measured from ICP/MS for fresh samples.

$N_{\text{O}}$ , uptake of oxygen atom calculated from  $\text{H}_2$  consumption in TPR.

volumetrically in a vacuum system described in a previous study (29). Obtained dispersions of platinum on reduced samples are listed in Tables 2 and 4.

## 2.7. XPS Characterizations

X-ray photoelectron spectra were obtained from a Perkin-Elmer PHI 1600 Spectrometer using a monochromatic  $\text{MgK}\alpha$  X-ray radiation ( $h\nu = 15$  keV) at a power of 250 W. The Si 2p peak (103.4 eV) of  $\text{SiO}_2$  (31) was used as an internal standard to calibrate the binding energy of peaks in obtained spectra.

## 2.8. $^{27}\text{Al}$ NMR Characterizations

$^{27}\text{Al}$  NMR spectra of silica-alumina supports were obtained from a Bruker MSL-200 spectrometer at an operating frequency of 39.73 MHz. A 3000-Hz magic angle spinning was performed during the signal collection. Reported chemical shifts were related to a standard peak of  $\text{Al}(\text{H}_2\text{O})_6^{+3}$ .

## 3. RESULTS AND DISCUSSION

### 3.1. Effects of Chloride Ions on Fresh Pt/ $\text{SiO}_2$ Samples

Figure 1 displays TPR traces from three fresh Pt/ $\text{SiO}_2$  samples of different Pt loadings. The Pt species on these samples may be regarded as  $\text{PtO}_x\text{Cl}_y$  complexes (15, 21) because they were prepared from  $\text{PtCl}_4$  precursor and calcined mildly at  $300^\circ\text{C}$ . The two reduction peaks observed

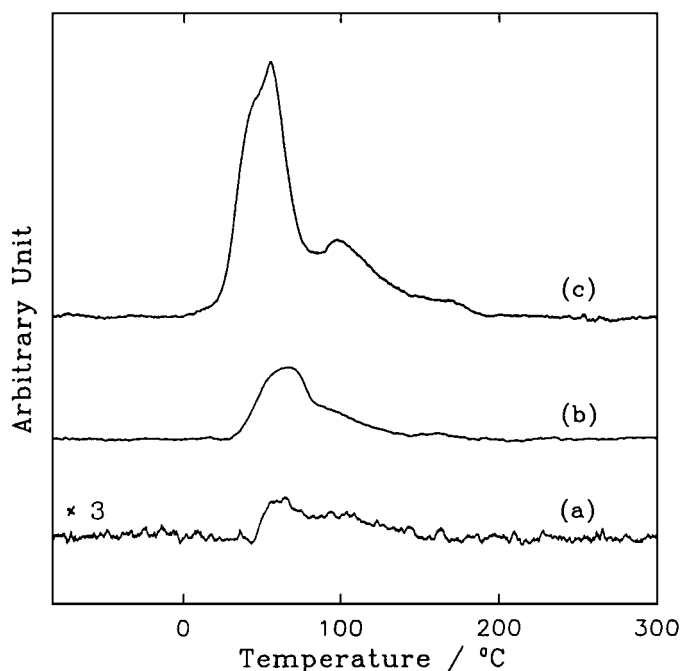
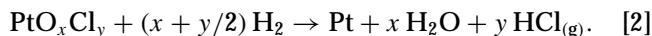


FIG. 1. TPR spectra for reduction of  $\text{PtO}_x\text{Cl}_y$  species on fresh Pt/ $\text{SiO}_2$  samples. (a) 0.2% Pt/ $\text{SiO}_2$ , (b) 1.0% Pt/ $\text{SiO}_2$ , (c) 4.9% Pt/ $\text{SiO}_2$ .

in Fig. 1 confirmed the literature suggestion (15) that two kinds of  $\text{PtO}_x\text{Cl}_y$  complexes, a bulk phase and a dispersive phase, coexisted on fresh platinum samples. The 4.9% Pt/SiO<sub>2</sub> sample consisted mainly of bulk  $\text{PtO}_x\text{Cl}_y$  which displayed a TPR peak at  $T_r \sim 60^\circ\text{C}$ . The dispersive phase of  $\text{PtO}_x\text{Cl}_y$  interacted substantially with SiO<sub>2</sub> support and exhibited a  $T_r \sim 100^\circ\text{C}$ .

Coordinated chloride ions in the  $\text{PtO}_x\text{Cl}_y$  complexes should be removed from platinum by TPR reduction (15, 21) through reactions of



Part of the  $\text{HCl}_{(g)}$  produced may be reabsorbed by the silica support and remained on the reduced samples.

### 3.2. Effects of Oxidation Treatments on Reduced Pt/SiO<sub>2</sub> Samples

Figure 2 shows a series of TPR characterizations for eight portions of a reduced 4.9% Pt/SiO<sub>2</sub> sample oxidized at different  $T_O$  temperatures. The oxidation reaction may be described by an equation of

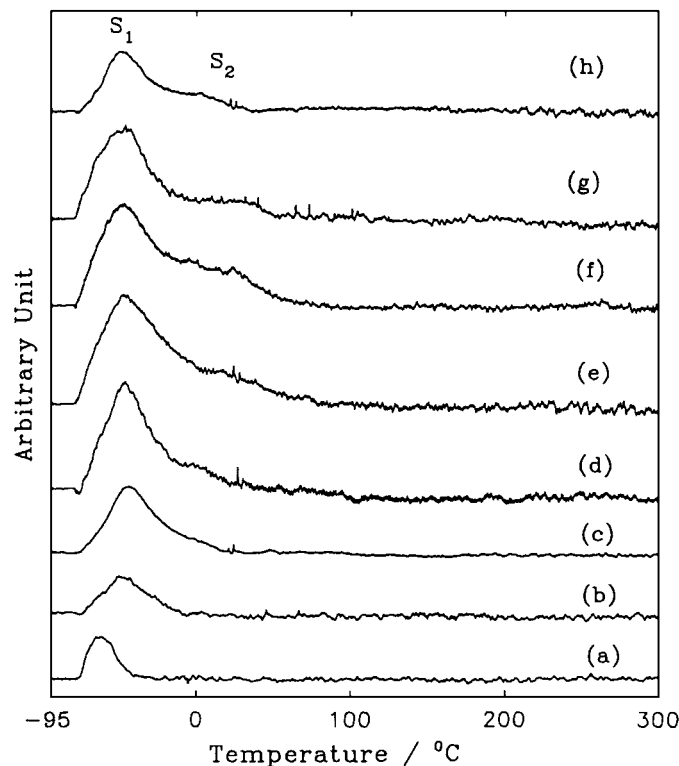


FIG. 2. TPR spectra of oxidized 4.9% Pt/SiO<sub>2</sub> samples which have been pretreated with a 2-h reduction in a flowing hydrogen at 300°C and a subsequent oxidation with 5% oxygen in He at  $T_O =$  (a)  $-10^\circ\text{C}$ , (b)  $-40^\circ\text{C}$ , (c)  $25^\circ\text{C}$ , (d)  $100^\circ\text{C}$ , (e)  $300^\circ\text{C}$ , (f)  $400^\circ\text{C}$ , (g)  $500^\circ\text{C}$ , and (h)  $600^\circ\text{C}$ .

Observed reduction temperatures for  $\text{PtO}_x$  species formed on oxidized samples are always lower than  $30^\circ\text{C}$ . A comparison of these TPR traces with those in Fig. 1 reveals that  $\text{PtO}_x$  species formed on oxidized samples exhibit reduction temperatures lower than that of  $\text{PtO}_x\text{Cl}_y$  complexes. The coordinated chloride ions on  $\text{PtO}_x\text{Cl}_y$  complexes can, indeed, be removed from platinum upon the prereduction treatment of Eq. [2].

TPR traces in Fig. 2 exhibited two dominant reduction peaks, i.e.,  $S_1$  ( $T_r = -50^\circ\text{C}$ ) and  $S_2$  ( $T_r = 20^\circ\text{C}$ ). Both Bond *et al.* (14) and Sachtler *et al.* (25) also noticed two reduction peaks with similar  $T_r$  temperatures from their Pt/SiO<sub>2</sub> samples oxidized at  $300^\circ\text{C}$  (Table 1). They reported that the platinum oxide formed on the oxidation had a stoichiometry of  $\text{PtO}_{0.9}$ . The observation of two reduction peaks in a reductive trace indicated that Pt oxides on the oxidized Pt/SiO<sub>2</sub> samples should have stayed in two different chemical environments. Sachtler *et al.* attributed their two peaks to reductions of PtO particles with different sizes. Bond *et al.*, however, suggested that two different morphologies of Pt oxides, i.e., a disordered nonstoichiometric  $\text{PtO}_x$  (with  $T_r = -60^\circ\text{C}$ ) and a stoichiometric PtO (with  $T_r = 20^\circ\text{C}$ ), coexisted on the EUROPT-1 catalysts. The assignment of these two reproducible peaks therefore remained in controversy.

In this study, both the relative area and the total area of  $S_1$  and  $S_2$  peaks in TPR traces were found to vary with the temperature  $T_O$  of the oxidation pretreatment (Table 2). Trace (a) of Fig. 2 indicates only a narrow peak at  $T_r = -60^\circ\text{C}$  with a  $N_O/N_{\text{Pt}}$  ratio = 0.23 after a  $-100^\circ\text{C}$  oxidation treatment. This low uptake stoichiometry suggests that the oxygen uptake might be limited to a chemisorption of platinum atoms ( $\text{Pt}^{\text{s}}$ ) exposed on the surface of Pt crystallites; i.e.,



The extent of oxidation should increase with the oxidation temperature and extend to sublayers of platinum crystallites on raising the  $T_O$  temperature from  $-100$  to  $100^\circ\text{C}$ . As a result, calculated  $N_O/N_{\text{Pt}}$  ratio gradually increased upward to 1.0 (traces b–d). Accordingly, the dominant species  $S_1$  formed at  $T_O = 100^\circ\text{C}$  is therefore assigned to the PtO structure formed from the following oxidation:



Surprisingly, the  $N_O/N_{\text{Pt}}$  ratio surpassed significantly the expected stoichiometry of 1.0 for PtO and a shoulder peak ( $S_2$ ) became evident when  $T_O$  temperature was raised over to  $300^\circ\text{C}$  (traces e–g). Through peak decomposition, areas of the merged  $S_1$  and  $S_2$  peaks in the traces of Fig. 2 were estimated and listed in Table 2. The calculated  $S_2/S_1$  ratio of these traces also increased with the oxidation temperature when  $T_O < 400^\circ\text{C}$ . Conceivably, a new species  $\text{PtO}_2$  was produced on the surface of supported platinum crystallites

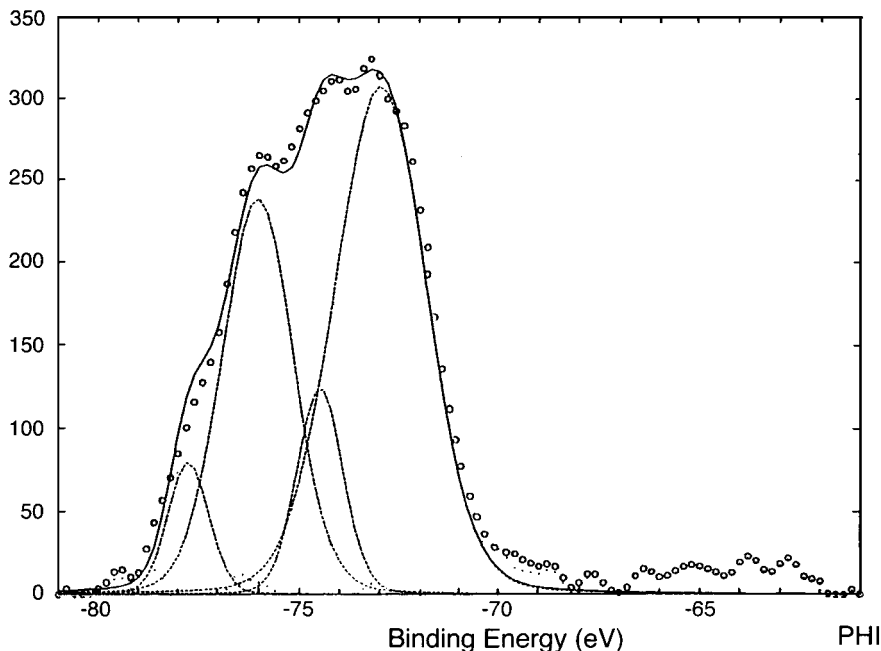
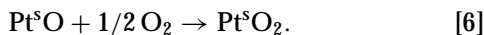


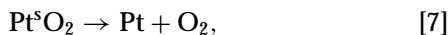
FIG. 3. XPS spectrum of Pt 4f signal for 4.9% Pt/SiO<sub>2</sub> sample oxidized at  $T_0 = 400^\circ\text{C}$ .

through an extended oxidation reaction:



Although PtO<sub>2</sub> has been found as the major platinum species on Pt/Al<sub>2</sub>O<sub>3</sub> samples oxidized at 400°C (21), formation of this species on Pt/SiO<sub>2</sub> samples has never been confirmed in literature. The 4.9% Pt/SiO<sub>2</sub> sample oxidized at  $T_0 = 400^\circ\text{C}$  was therefore examined by XPS spectroscopy (Fig. 3). Interestingly, besides the PtO signals (Pt 4f binding energy of 73.1 and 76.4 eV), signals for PtO<sub>2</sub> (74.6 and 77.9 eV) were also observed. The relative intensity (7 to 3) of their signals is in good agreement with the molar ratio of PtO to PtO<sub>2</sub> determined by TPR for the oxidized sample (Table 2).

A decrease in the  $N_{\text{O}}/N_{\text{Pt}}$  ratio was found in Table 2 on raising  $T_0$  temperature above 400°C. The decrease in stoichiometry of PtO<sub>x</sub> at high oxidation temperatures may be resulted by either a decomposition of Pt<sup>S</sup>O<sub>2</sub> (21), i.e.,



or a sublimation of Pt<sup>S</sup>O<sub>2</sub> (Reaction [1]). The ICP-MS analysis for platinum loadings (Table 2) confirmed the sublimation process at  $T_0 > 400^\circ\text{C}$ . It is noteworthy that a sublimation of PtO<sub>2(g)</sub> has also been observed on Pt/Al<sub>2</sub>O<sub>3</sub> samples (21), although the extent of PtO<sub>2(g)</sub> sublimation from Pt/Al<sub>2</sub>O<sub>3</sub> samples was relatively mild.

Both peaks of PtO and Pt<sup>S</sup>O<sub>2</sub> reduction appeared also in the TPR traces (Fig. 4) of reoxidized 1.0% Pt/SiO<sub>2</sub> samples. However, the intensity of peak S<sub>2</sub> (Pt<sup>S</sup>O<sub>2</sub> reduction) became

most prominent for a 500°C oxidation (trace (c) of Fig. 4) in contrast to the result discussed above for the higher loaded 4.9% Pt/SiO<sub>2</sub> sample. Probably, highly dispersed platinum particles on a lowly loaded Pt/SiO<sub>2</sub> sample are easier to

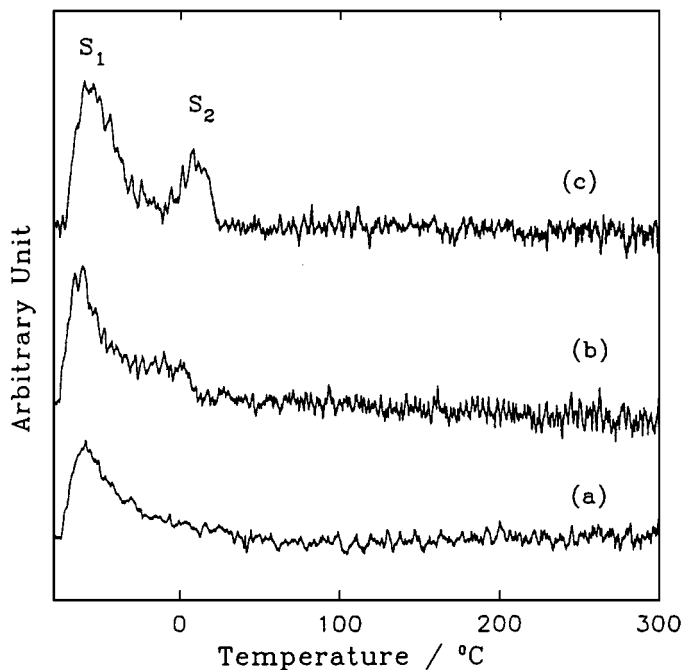


FIG. 4. TPR spectra of oxidized 1.0% Pt/SiO<sub>2</sub> samples which have been pretreated with a 2-h reduction in a flowing hydrogen at 300°C and a subsequent oxidation with 5% oxygen in He at  $T_0 =$  (a) 25°C, (b) 300°C, and (c) 500°C.

convert into  $\text{Pt}^{\circ}\text{O}_2$  upon a  $500^\circ\text{C}$  oxidation. Similar particle size effects have also been previously found from oxidations of  $\text{Pt}/\text{Al}_2\text{O}_3$  samples (21, 24).

Table 3 summarizes TPR characterizations made in this study and a previous report (21) for different platinum species dispersed on  $\text{SiO}_2$  and  $\text{Al}_2\text{O}_3$  supports. Observed  $T_r$  temperatures vary significantly with chemical environments, i.e., the oxidation state and the dispersing support. Platinum species dispersed on  $\text{SiO}_2$  supports generally exhibit lower  $T_r$  temperatures than those dispersed on  $\text{Al}_2\text{O}_3$  supports. Observed differences in the reduction behavior of platinum species probably arise from variations in the extent of metal-support interactions.

Upon oxidation treatments at  $T_O \geq 400^\circ\text{C}$ , vaporized platinum oxides were found to diffuse into the sublayers of alumina supports to form a  $\text{PtAl}_2\text{O}_4$  spinal structure (21). The corresponding reduction of platinum silicate at  $T_r \sim 500^\circ\text{C}$  (32) was absent in TPR traces of  $\text{Pt}/\text{SiO}_2$  samples even when severely oxidized at  $T_O \geq 400^\circ\text{C}$ . Observed substantial sublimation of  $\text{PtO}_{2(g)}$  from  $\text{Pt}/\text{SiO}_2$  samples, on comparing with  $\text{Pt}/\text{Al}_2\text{O}_3$  (21), at  $T_O \geq 400^\circ\text{C}$  (reaction [1]) should be a consequence of the low affinity between platinum and the silica support.

### 3.3. Effects of Oxidation Temperature on Pt/SA-40 Samples

Figure 5 shows TPR traces from different portions of a reduced Pt/SA-40 sample (its silica-alumina support

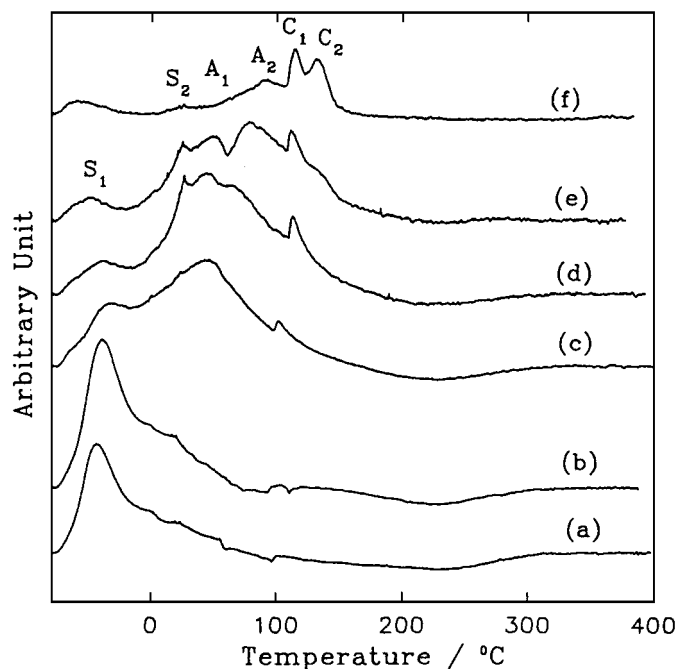


FIG. 5. TPR spectra of oxidized 4.8% Pt/SA40 samples with  $T_0 =$  (a)  $25^\circ\text{C}$ , (b)  $100^\circ\text{C}$ , (c)  $300^\circ\text{C}$ , (d)  $400^\circ\text{C}$ , (e)  $500^\circ\text{C}$ , and (f)  $600^\circ\text{C}$ .

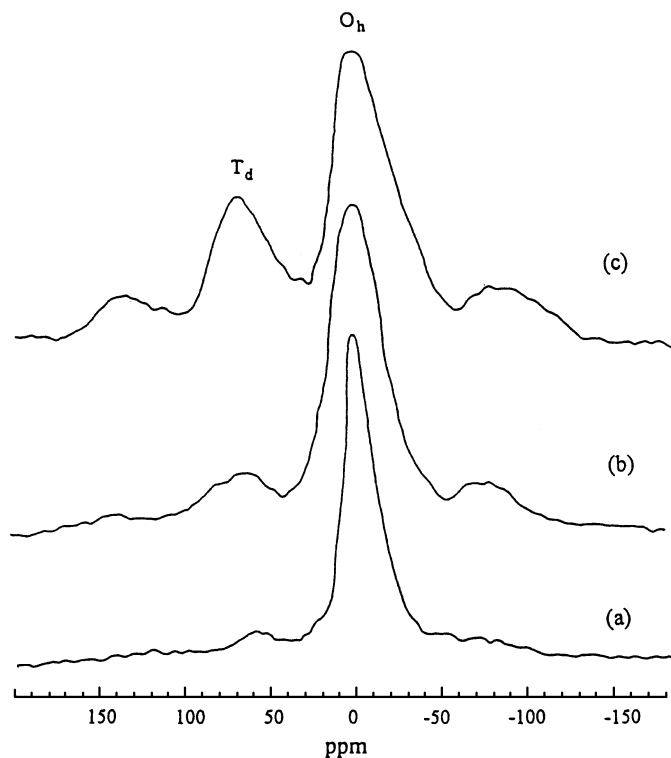


FIG. 6. Variation of  $^{27}\text{Al}$  NMR spectra with the composition of silica-alumina supports. (a) SA80, (b) SA75, (c) SA40.

has a  $\text{SiO}_2/\text{Al}_2\text{O}_3$  weight ratio = 40/60) oxidized at different temperatures. These traces are composed mainly of six reduction peaks. They are tentatively designated as species  $S_1$  ( $T_r \sim -40^\circ\text{C}$ ),  $S_2$  ( $T_r \sim 20^\circ\text{C}$ ),  $A_1$  ( $T_r \sim 50^\circ\text{C}$ ),  $A_2$  ( $T_r \sim 90^\circ\text{C}$ ),  $C_1$  ( $T_r \sim 110^\circ\text{C}$ ), and  $C_2$  ( $T_r \sim 130^\circ\text{C}$ ), respectively. The existence of these six peaks suggests that Pt atoms on the oxidized Pt/SA-40 samples have at least six distinct chemical environments. According to the characterization of Table 3, two peaks at low  $T_r$  temperatures ( $S_1$  and  $S_2$ ) in Fig. 5 are very similar to the reduction peaks of PtO and  $\text{PtO}_2$  species dispersed on  $\text{Pt}/\text{SiO}_2$  samples. The middle two  $T_r$  peaks ( $A_1$  and  $A_2$ ) in traces (c-f) of Fig. 5 are similar to the reduction peaks of PtO and  $\text{PtO}_2$  species dispersed on  $\text{Pt}/\text{Al}_2\text{O}_3$  samples (21). Probably, the SA-40 support contains two kinds of domains, i.e., a silica-rich phase and an alumina-rich phase.

Figure 6 shows  $^{27}\text{Al}$  NMR spectra for a series of silica-alumina supports. These spectra contained two peaks with chemical shift of  $\delta = 0$  and 50 ppm. They are assigned to aluminum ions in octahedral ( $O_h$ ) and tetrahedral ( $T_d$ ) structures, respectively. Minor side bands are also noticed because the rate ( $\sim 3000$  Hz) of magic angle spin during the signal accumulation was not high enough. Trace (a) of Fig. 6 for SA-80 support (with a  $\text{SiO}_2/\text{Al}_2\text{O}_3$  weight ratio = 80/20) exhibits a single peak with chemical shift at  $\delta = 0$  ppm. Obviously, most aluminum ions in this silica-alumina support

aggregated themselves as alumina and interacted negligibly with the  $\text{SiO}_2$  components. In other words, the silica-alumina support was indeed constituted mainly by two phases, i.e., silica-rich grains and alumina-rich grains. Evidently, the  $S_1$  and  $S_2$  peaks in Fig. 5 indicate that some of impregnated Pt stayed on the silica-rich grains and formed PtO and  $\text{PtO}_2$  species during oxidation processes. The  $A_1$  and  $A_2$  peaks in Fig. 5 should come from reductions of PtO and  $\text{PtO}_2$  species residing on the alumina-rich grains of the support.

A minor  $T_d$  peak ( $\delta = 50$  ppm) became prominent in traces (b) and (c) of Fig. 6 as the  $\text{SiO}_2/\text{Al}_2\text{O}_3$  ratio of  $\text{SiO}_2$ - $\text{Al}_2\text{O}_3$  supports was decreased. The appearance of the  $T_d$  peak indicates that a small fraction of aluminum ions in the support mixed intimately with  $\text{SiO}_2$  components. Garofalini *et al.* (33) have verified in a computer-simulation study that cage structures were formed in the interface regions between silica-rich grains and alumina-rich grains during sol-gel preparations of silica-alumina. The  $T_d$  peak in trace (c) of Fig. 6 may be attributed to a formation of short ranged zeolite structure at the  $\text{SiO}_2$ - $\text{Al}_2\text{O}_3$  grain boundaries of the SA-40 support.

The appearance of species  $C_1$  and  $C_2$  ( $T_r = 110$  and  $130^\circ\text{C}$ , respectively) in Fig. 5 suggests that the chemical environments of some Pt species are rather different from those dispersed on either pure  $\text{SiO}_2$  or  $\text{Al}_2\text{O}_3$  support. Based on TPR characterizations, both Sachtler *et al.* (25, 34) and Foger *et al.* (35) demonstrated that platinum ions in the supercage of Y zeolite and in the channel of L zeolite have  $T_r$  temperatures around  $100$ - $150^\circ\text{C}$ . Based on the NMR results, both  $C_1$  and  $C_2$  peaks in Fig. 5 could come from reductions of Pt cations residing in pores of the zeolite structures at  $\text{SiO}_2$ - $\text{Al}_2\text{O}_3$  grain boundaries. These two peaks probably reflect reductions of platinum ion with two different oxidation states.

#### 3.4. Influence of $\text{SiO}_2$ - $\text{Al}_2\text{O}_3$ Support Composition on the Distribution of Pt Species

$^{27}\text{Al}$  NMR spectra in Fig. 6 show that the  $T_d$  peak gradually disappeared with increasing the  $\text{SiO}_2/\text{Al}_2\text{O}_3$  ratios of the  $\text{SiO}_2$ - $\text{Al}_2\text{O}_3$  supports (from SA-40, SA-75, to SA-80). The reduction of the  $T_d$  peak reveals that the formation of zeolite pores at  $\text{SiO}_2$ - $\text{Al}_2\text{O}_3$  grain boundaries becomes negligible and that silica-rich grains and alumina-rich grains become dominant in the samples with high Si content.

Figure 7 compares the TPR traces from different Pt/SA samples (supports with  $\text{SiO}_2/\text{Al}_2\text{O}_3$  weight ratio = 0, 40/60, 75/25, 80/20, and  $\infty$ , respectively) oxidized at  $T_O = 500^\circ\text{C}$  to study the effect of support composition. Observed changes of the TPR traces in Fig. 7 indicate variations in the distribution of different platinum species with the support composition. Peaks of  $S_1$  and  $S_2$  (PtO and  $\text{PtO}_2$  on silica-rich grains) were favored on a Pt/SA-80 sample. However, the intensities of these two signals were gradually decreased and replaced by the  $A_1$  and the  $A_2$  signals (PtO and  $\text{PtO}_2$  on

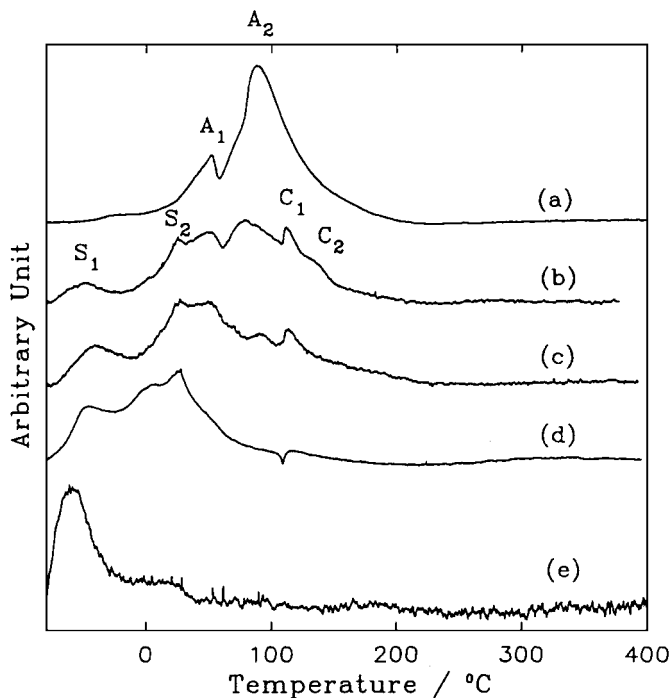


FIG. 7. A comparison of TPR spectra from different supported platinum samples oxidized at  $T_0 = 500^\circ\text{C}$ . (a) 5.0% Pt/ $\text{Al}_2\text{O}_3$ , (b) 4.8% Pt/SA40, (c) 4.9% Pt/SA75, (d) 4.8% Pt/SA80, (e) 4.9% Pt/ $\text{SiO}_2$ .

alumina-rich grains) as the  $\text{Al}_2\text{O}_3/\text{SiO}_2$  ratio of the support was increased. Evidently,  $\text{SiO}_2$  and SA-80 supports lead to a formation of species  $S_1$  and  $S_2$ , while  $\text{Al}_2\text{O}_3$  and SA-40 supports promote a formation of species  $A_1$  and  $A_2$ . On the SA-40 support (with a near equilateral  $\text{SiO}_2/\text{Al}_2\text{O}_3$  weight ratio), an appreciative fraction of platinum atoms tend to spread into the cage structures.

#### 4. CONCLUSIONS

Through a combination of XPS characterization, TPR study, and ICP determination, both PtO and  $\text{PtO}_2$  species has been verified to coexist on silica supports. The ratio of  $\text{PtO}_2/\text{PtO}$  on Pt/ $\text{SiO}_2$  samples varied with the dispersion of platinum crystallites as well as the oxidation temperature. The  $\text{PtO}_2$  dispersed on  $\text{SiO}_2$  support is unstable under severe oxidation environment (at  $T_O \geq 400^\circ\text{C}$ ) and tends to sublime into  $\text{PtO}_{2(g)}$  vapor (reaction [1]). In addition, platinum-oxide species of six different chemical environments were distinguished from the Pt/SA samples. They were assigned to PtO and  $\text{PtO}_2$  dispersed on silica-rich grains (with  $T_r = -40$  and  $20^\circ\text{C}$ ), on alumina-rich grains (with  $T_r = 50$  and  $90^\circ\text{C}$ ), and in cages at grain boundaries (with  $T_r$  about  $110$ - $130^\circ\text{C}$ ), respectively.

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